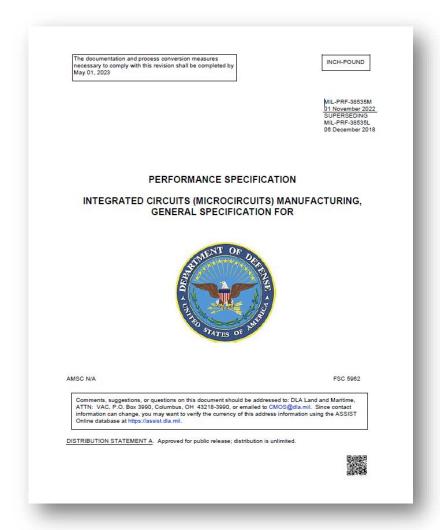


MIL-PRF-38535 specification

- Developed in the late 1980's and still the key standard for defense & space grade semiconductors, the MIL-PRF-38535 specification was driven in JEDEC with support from DLA, NASA and other industry experts.
- To have the Defense Logistic Agency (DLA) assign and release a SMD 5962-xxxx spec, all the Qualified Manufacturer List (QML) programs and requirements must be followed including audits of each of the manufacturing sites.





Advanced, Reliable, QML Worldwide Production



MIHO

- 200mm wafers
- CMOS & BiCMOS
- Miho, Japan



SFAB

- · 200mm wafers
- Bipolar, CMOS & BiCMOS
- · Sherman, Texas



FFAB

- 200mm wafers
- CMOS & BiCMOS
- Freising, Germany



DMOS 5

- · 200mm wafers
- CMOS & BiCMOS
- Dallas, Texas
- 350 130 nm



MFAB

- 200mm wafers
- CMOS & BiCMOS
- · South Portland, Maine
- 250 130nm



RFAB 1 & RFAB 2

- 300mm wafers
- CMOS & BiCMOS
- Richardson, Texas
- 350 130nm



DMOS 6

- · 300mm wafers
- CMOS
- Dallas, Texas
- 350 65nm

Setting a new standard for electronics in space

QML Class P

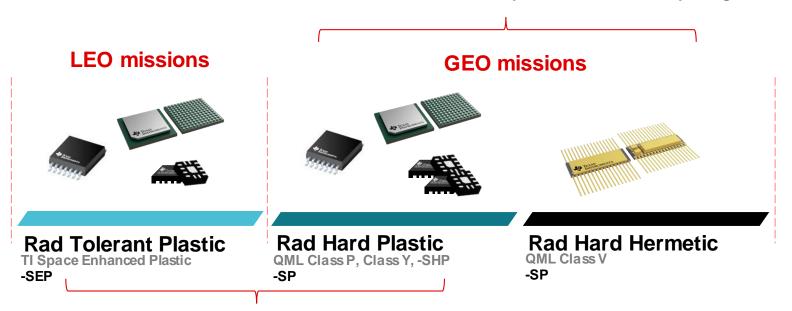
- Hermetic QML Class V for space & hermetic QML Class Q for defense systems have been part of the MIL standard for many years.
- Until QML Class P there had not been any standardized use of plastic packaging specifically for the space environment.
- For TI's first QMLP releases are on the same SMD as our QMLV devices and are assigned a 5962xxxxxxPYE orderable part number

	Rating			Space		
	Classification	Space EP	SHP	QML-P	QML-Y	QML-V
	Vendor item drawing (VID)	✓	~	×	×	×
Production testing	Standard microcircuit drawing (SMD)	×	×	✓	✓	✓
and documentation provided	Process conformance report	✓	✓	✓	✓	✓
•	Process conformance report content	See product page		MIL- PRF-38535 Group A, B, C, D, E		
	Single controlled baseline	✓	~	✓	✓	✓
Manufacturing	Multiple wafer lots per reel possible	×	×	×	×	×
	Life test per wafer lot	×	~	✓	✓	✓
	Package construction	Plastic	Plastic	Plastic - Wirebond or flip chip with overmold	Plastic - flip chip w/o overmold	Hermetic
	Bond wires	Au	Au	Au	N/A	Al
Packaging	Pure tin (Sn) lead finish possible?	×	×	×	×	×
ruokuging	>97% Tin (Sn) inside package possible*	✓ for f		f p chip		×
	Production burn-in required	×	~	✓	✓	~
	Outgassing tested per ASTM E595	✓	✓	✓	✓	N/A
	TID characterization range (krad/Si)	30 to 50		50 to 3	3)0	
Radiation	TID radiation lot acceptance testing (RLAT) range – RHA (krad/Si)	20, 30 or 50		50, 100 o 300		
	SEL immunity (MeV*cm2/mg)	≥ 43		≥ 60		
Typical temperature range				−55−125°C		
Table illustrates typical values for each Classification rating. For precise data or detailed information, please refer to the product-specific page.		TID = Total Ioni VID = Vendor It	•	RHA = Radiation Hardness Assur QML = Qualifed Manufacturers Li	is t	
* BI unless Optimization aligned with DLA		SEL= Single-Event Latch-up		SMD = Standard Microcircuit Dra	ving	



TI Space product grades

Same radiation levels, same qualification, different package



Pin-to-pin compatible, different radiation levels

		1	
Packaging	Plastic	Plastic	Ceramic / Metal Can
Mil. Spec	Vendor Item Drawing	Standard N	/licrocircuit Drawing
Burn- in	No	Yes	Yes
TID Char	30 - 50 krad(Si)	< 50 – 30	00 krad(Si)>
TID RLAT	20, 30, or 50 krad(Si)	<> Non-RHA, 50, 100, or 300 krad(Si)	
SEL	43 MeV⋅cm²/mg		

TI's Rad-hard plastic power portfolio as of Feb 2024

Product or Part number	DLA SMD #	Subcategory	Status
<u>TPS7H4001-SP</u>	<u>5962-18205</u>	Buck converters	ACTIVE
<u>TPS7H1111-SP</u>	<u>5962-21203</u>	Linear LDO regulators	ACTIVE
<u>TPS7H3302-SP</u>	<u>5962-14228</u>	DDR memory power ICs	ACTIVE
<u>TPS7H5001-SP</u>	<u>5962-18222</u>	PWM controllers	ACTIVE
<u>TPS7H2211-SP</u>	<u>5962-18220</u>	eFuse controllers	ACTIVE
<u>TPS7H2201-SP</u>	<u>5962-17220</u>	eFuse controllers	ACTIVE

Additional released TI Rad-hard plastic categories include:

- High speed data converter
- High speed clocking & timing devices
 - Low-power microcontrollers

With many more devices throughout 2024 & beyond

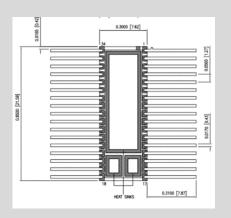


- Significant reduction in board area vs equivalent hermetic offerings
- Improved electrical specifications for high-speed signal chain devices
- Reduced mass vs hermetic equivalent offerings
- Improved thermal performance vs hermetic equivalent offerings
- Option for pin-to-pin option covering a wider range of missions

Benefits in plastic flat packs (roughly half the package size of hermetic options)

Switching regulator

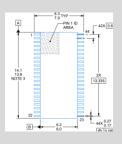
TI TPS7H4001-SP 18A Ceramic QMLV 5962R1820501VXC



Pkg Size w/2mm leads: 21.8mm x 11.8mm = 257mm²

Power density w/1V output ~70 mW/mm²

TI TPS7H4001-SP 18A Plastic QMLP 5962R1820502PYE

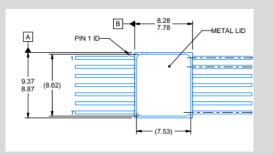


Pkg Size w/leads: 14.1mm x 8.3mm = 117mm²

Power density w/1V output ~154 mW/mm²

Linear regulator

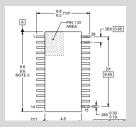
TI TPS7H1111-SP 1.5A Ceramic QMLV 5962R2120301VXC



Pkg Size w/2mm leads: 9.3mm x 12.3mm = 115mm²

Power density w/1V output ~13 mW/mm²

TI TPS7H1111-SP 1.5A Plastic QMLP 5962R2120302PYE



Pkg Size w/leads: 9.8mm x 6.6mm = 65mm²

Power density w/1V output ~23 mW/mm²

- Significant reduction in board area vs equivalent hermetic offerings
- Improved electrical specifications for high-speed signal chain devices
 - The relative permittivity of the plastic packages is ~3.7; for ceramic, it is ~9.8. As a result, capacitive coupling for plastic packages is over 2.5 times less, thus improving crosstalk
 - The lower capacitance plastic substrates improve the bandwidth and return loss
- Reduced mass vs hermetic equivalent offerings
- Improved thermal performance vs hermetic equivalent offerings
- Option for pin-to-pin option covering a wider range of missions

- Significant reduction in board area vs equivalent hermetic offerings
- Improved electrical specifications for high-speed signal chain devices
- Reduced mass vs hermetic equivalent offerings
 - TPS7H4001-SP QMLV ceramic package (34-pin CDFP) mass is 2612mg
 - TPS7H4001-SP QMLP plastic package (44-pin HTSSOP) mass is 243mg = ~ 90% less
 - TPS7H1111-SP QMLV ceramic package (14-pin CDFP) mass is 1230mg
 - TPS7H1111-SP QMLP plastic package (28-pin HTSSOP) mass is 198mg = ~ 80% less
- Improved thermal performance vs hermetic equivalent offerings
- Option for pin-to-pin option covering a wider range of missions

- Significant reduction in board area vs equivalent hermetic offerings
- Improved electrical specifications for high-speed signal chain devices
- Reduced mass vs hermetic equivalent offerings
- Improved thermal performance vs hermetic equivalent offerings
 - Traditional ceramic packages place the die in a cavity, this leaves an airgap between the die and the metal lid. With flip-chip BGA -SHP packaging, the metal lid connects to the back of the flip-chip die directly.
 - TI has seen an improvement in thermal efficiency from the die to the package, with the thermal resistance reducing from ~16 C/W in column-grid array ceramic packages to ~0.8 C/W in plastic BGA packages.
- Option for pin-to-pin option covering a wider range of missions

- Significant reduction in board area vs equivalent hermetic offerings
- Improved electrical specifications for high-speed signal chain devices
- Reduced mass vs hermetic offerings
- Improved thermal performance vs hermetic offerings
- Option for pin-to-pin option covering a wider range of missions
 - Many of Tl' rad-hard plastic devices (-SP) will be offered in a pin-to-pin rad-tolerant plastic (-SEP) variant
 - The objective of this is to provide designers more options and more flexibility to enable maximum reuse and to have a common architecture for LEO, MEO and/or GEO missions.

Tl's Rad-hard plastic power portfolio as of Feb 2024

Product or Part number	DLA SMD #	Subcategory	-SEP Pin-to-Pin option
TPS7H4001-SP	<u>5962-18205</u>	Buck converters	<u>TPS7H4003-SEP</u>
<u>TPS7H1111-SP</u>	<u>5962-21203</u>	Linear LDO regulators	<u>TPS7H1111-SEP</u>
<u>TPS7H3302-SP</u>	<u>5962-14228</u>	DDR memory power ICs	<u>TPS7H3302-SEP</u>
TPS7H5001-SP	<u>5962-18222</u>	PWM controllers	<u>TPS7H5005-SEP</u>
<u>TPS7H2211-SP</u>	<u>5962-18220</u>	eFuse controllers	<u>TPS7H2211-SEP</u>
TPS7H2201-SP	<u>5962-17220</u>	eFuse controllers	TPS7H2201-SEP

TI plastic space power portfolio as of Feb 2024

Classification	Product or Part number	Subcategory	Radiation, TID (typ) (krad)	Radiation, SEL (MeV·cm2/mg)
	TPS7H3302-SP	DDR memory power ICs	100	72
	<u>TPS7H1111-SP</u>	Linear & low-dropout (LDO) regulators	100	75
Rad-hard	<u>TPS7H2211-SP</u>	eFuses & hot swap controllers	100	75
QMLP	TPS7H5001-SP	PWM controllers	100	75
	TPS7H4001-SP	Buck converters (integrated switch)	100	75
	TPS7H2201-SP	eFuses & hot swap controllers	100	75
	<u>TPS7H2140-SEP</u>	eFuses & hot swap controllers	30	43
	<u>TPS7H2201-SEP</u>	eFuses & hot swap controllers	50	43
	<u>TPS7H2211-SEP</u>	eFuses & hot swap controllers	50	43
	<u>TPS7H1111-SEP</u>	Linear & low-dropout (LDO) regulators	50	43
	<u>TPS7H3302-SEP</u>	DDR memory power ICs	50	43
	<u>TPS7H2221-SEP</u>	Load switches	30	43
Rad-tolerant	<u>TPS7H5005-SEP</u>	PWM controllers	50	43
-SEP	<u>TPS7H5008-SEP</u>	PWM controllers	50	43
-3EF	<u>TPS7H5007-SEP</u>	PWM controllers	50	43
	<u>TPS7H5006-SEP</u>	PWM controllers	50	43
	<u>TPS7H4003-SEP</u>	Buck converters (integrated switch)	50	43
	<u>TPS7H1210-SEP</u>	Linear & low-dropout (LDO) regulators	30	43
	<u>TPS7H4010-SEP</u>	Buck converters (integrated switch)	30	43
	<u>TL7700-SEP</u>	Supervisor & reset ICs	30	43
	<u>TPS73801-SEP</u>	Linear & low-dropout (LDO) regulators	50	43



Getting started

You can start evaluating these devices leveraging the following:

Content type	Content title	Link to content or more details
Selection Guide	TI Space Products Guide	https://www.ti.com/lit/sg/slyt532i/slyt532i.pdf
Technical Article	Setting a new standard for electronics in space	https://news.ti.com/setting-a-new-standard-for- electronics-in-space
Parametric Table	View our QML Class P, Y and SHP products	https://www.ti.com/applications/industrial/aerospace- ce-defense/space/products.html#2954=FCCSP%3B HTQFP%3BHTSSOP%3BSOIC%3BSOT- 223%3BSOT-23-THN%3BSOT- SC70%3BSSOP%3BTSSOP%3BVQFN%3BVQ FNP%3BVSSOP%3BWQFN&-1=-SP%3Bfalse&



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